# imall

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## FAIRCHILD

SEMICONDUCTOR®

# FMG2G50US120

## Molding Type Module

## **General Description**

Fairchild IGBT Power Module provides low conduction and switching losses as well as short circuit ruggedness. It's designed for the applications such as motor control, uninterrupted power supplies (UPS) and general inverters where short-circuit ruggedness is required.

## Features

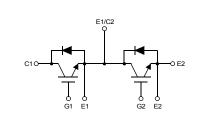
- Short Circuit Rated Time; 10us @  $T_C$  =100°C,  $V_{GE}$  = 15V
- High Speed Switching
- Low Saturation Voltage :  $V_{CE(sat)}$  = 2.6 V @ I<sub>C</sub> = 50A
- High Input Impedance
- Fast & Soft Anti-Parallel FWD
- UL Certified No.E209204

## Application

- AC & DC Motor Controls
- General Purpose Inverters
- Weldings
- Servo Controls
- UPS



Package Code : 7PM-GA



#### Internal Circuit Diagram

## Absolute Maximum Ratings T<sub>c</sub> = 25°C unless otherwise noted

Symbol	Description		FMG2G50US120	Units
V <sub>CES</sub>	Collector-Emitter Voltage	1200	V	
V <sub>GES</sub>	Gate-Emitter Voltage	Gate-Emitter Voltage		V
I <sub>C</sub>	Collector Current	50	А	
I <sub>CM (1)</sub>	Pulsed Collector Current	100	А	
I <sub>F</sub>	Diode Continuous Forward Current	50	А	
I <sub>FM</sub>	Diode Maximum Forward Current		100	А
P <sub>D</sub>	Maximum Power Dissipation		320	W
T <sub>SC</sub>	Short Circuit Withstand Time	@ T <sub>C</sub> = 100°C	10	us
TJ	Operating Junction Temperature		-40 to +150	°C
T <sub>STG</sub>	Storage Temperature Range		-40 to +125	°C
V <sub>ISO</sub>	Isolation Voltage	@ AC 1minute	2500	V
Mounting Torque	Power Terminal Screw : M5		4.0	N.m
Mounting Torque	Mounting Screw : M5		4.0	N.m

Notes :

(1) Repetitive rating : Pulse width limited by max. junction temperature

# IGBT

FMG2G50US120

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Cha	racteristics					
BV <sub>CES</sub>	Collector-Emitter Breakdown Voltage	V <sub>GE</sub> = 0V, I <sub>C</sub> = 3mA	1200			V
ΔB <sub>VCES</sub> / ΔT <sub>J</sub>	Temperature Coeff. of Breakdown Voltage	V <sub>GE</sub> = 0V, I <sub>C</sub> = 1mA		0.6		V/°C
I <sub>CES</sub>	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0V$			3	mA
I <sub>GES</sub>	Gate - Emitter Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0V$			± 100	nA
On Cha	racteristics					
V <sub>GE(th)</sub>	Gate - Emitter Threshold Voltage	$I_{C}$ =50mA, $V_{CE}$ = $V_{GE}$	5.0	7.0	8.5	V
V <sub>CE(sat)</sub>	Collector to Emitter Saturation Voltage	I <sub>C</sub> = 50A, V <sub>GE</sub> = 15V		2.6	3.0	V
tr	Rise Time			80		ns
t d(off)	Turn-Off Delay Time	$V_{CC} = 600 \text{ V}, \text{ I}_{C} = 50\text{ A},$		400		ns
ł	Fall Time	$R_G = 10\Omega$ , V <sub>GE</sub> = 15V, Inductive Load, T <sub>C</sub> = 25°C		65	150	ns
E <sub>on</sub>	Turn-On Switching Loss			4.68		mJ
E <sub>off</sub>	Turn-Off Switching Loss			3.48		mJ
t <sub>d(on)</sub>	Turn-On Delay Time			175		ns
t <sub>r</sub>	Rise Time			75		
-		$V_{CC} = 600 \text{ V}$ Ic = 50A				ns
t <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>CC</sub> = 600 V, I <sub>C</sub> = 50A, R <sub>G</sub> =10Ω, V <sub>GE</sub> = 15V,		390		ns
t <sub>d(off)</sub> t <sub>f</sub>	Turn-Off Delay Time Fall Time	$V_{CC} = 600 \text{ V, I}_{C} = 50\text{ A,}$ - $R_{G} = 10\Omega$ , $V_{GE} = 15\text{ V,}$ - Inductive Load, $T_{C} = 125^{\circ}\text{C}$		120		ns ns
t <sub>d(off)</sub> t <sub>f</sub> E <sub>on</sub>	Turn-Off Delay Time Fall Time Turn-On Switching Loss	R <sub>G</sub> =10Ω, V <sub>GE</sub> = 15V,		120 5.6		ns ns mJ
d(off) f E <sub>on</sub>	Turn-Off Delay Time Fall Time	$R_G = 10\Omega$ , $V_{GE} = 15V$ , Inductive Load, $T_C = 125^{\circ}C$	  	120		ns ns
t <sub>d(off)</sub> t <u>f</u> E <sub>on</sub> E <sub>off</sub> T <sub>sc</sub>	Turn-Off Delay Time   Fall Time   Turn-On Switching Loss   Turn-Off Switching Loss   Short Circuit Withstand Time	R <sub>G</sub> =10Ω, V <sub>GE</sub> = 15V,		120 5.6 4.4 		ns ns mJ
t <sub>d(off)</sub> t <sub>f</sub> E <sub>on</sub> E <sub>off</sub> T <sub>sc</sub> Q <sub>g</sub>	Turn-Off Delay Time   Fall Time   Turn-On Switching Loss   Turn-Off Switching Loss   Short Circuit Withstand Time   Total Gate Charge	$R_{G} = 10\Omega, V_{GE} = 15V,$ Inductive Load, $T_{C} = 125^{\circ}C$ $V_{CC} = 600 V, V_{GE} = 15V$ @ $T_{C} = 100^{\circ}C$		120 5.6 4.4  400		ns ns mJ mJ us nC
t <sub>d(off)</sub> t <sub>f</sub>	Turn-Off Delay Time   Fall Time   Turn-On Switching Loss   Turn-Off Switching Loss   Short Circuit Withstand Time	$R_G = 10\Omega$ , $V_{GE} = 15V$ , Inductive Load, $T_C = 125^{\circ}C$	 10	120 5.6 4.4 		ns ns mJ mJ us

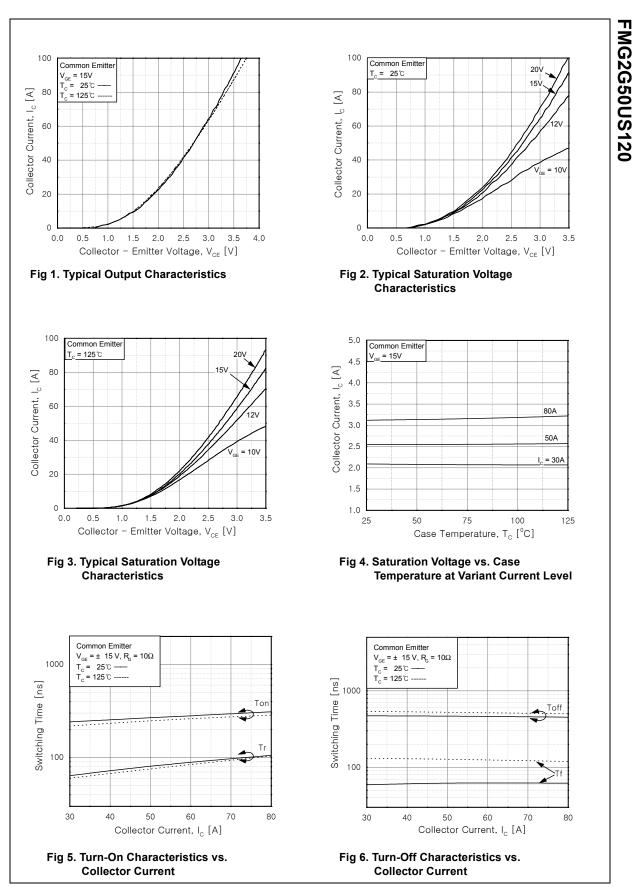
## Electrical Characteristics of DIODE T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Unit s
V Diada	Diada Eanward Valtaga	I <sub>F</sub> = 50A	$T_{\rm C}$ = 25°C		2.3	3.0	V
V <sub>FM</sub>	FM Diode Forward Voltage		T <sub>C</sub> = 125°C		2.2		
+	Diede Boyerge Besovery Time		$T_C = 25^{\circ}C$		160		20
t <sub>rr</sub>	Diode Reverse Recovery Time		T <sub>C</sub> = 125°C		220		ns
1	Diode Peak Reverse Recovery	I <sub>F</sub> = 50A	$T_{\rm C} = 25^{\circ}{\rm C}$		29		Δ
Irr	Current	di / dt = 700 A/us	T <sub>C</sub> = 125°C		36		A
0	Diede Deverse Desevery Charge		$T_C = 25^{\circ}C$		2320		
Q <sub>rr</sub>	Diode Reverse Recovery Charge		T <sub>C</sub> = 125°C		3960		nC

## **Thermal Characteristics**

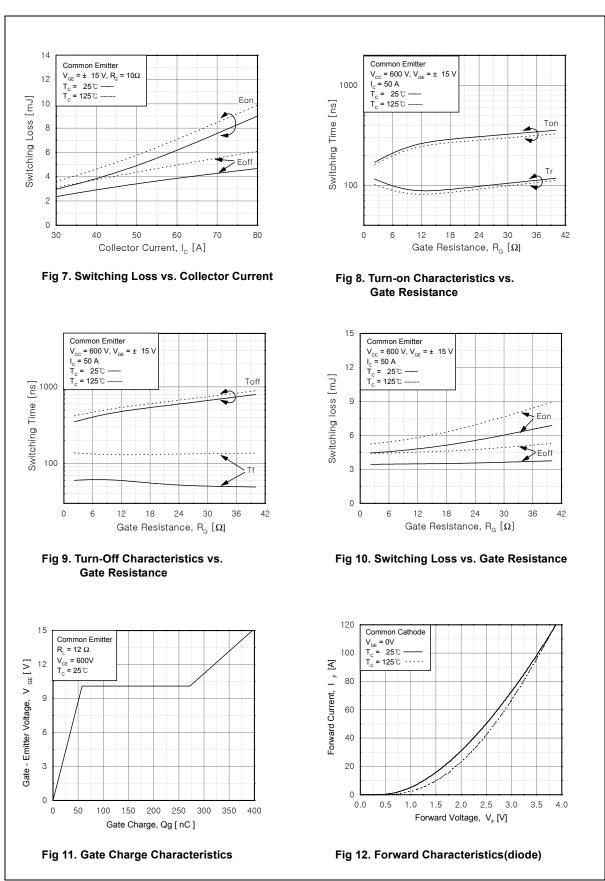
Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case (IGBT Part, per 1/2 Module)		0.39	°C/W
R <sub>θJC</sub>	Junction-to-Case (DIODE Part, per 1/2 Module)		0.47	°C/W
$R_{\theta JC}$	Case-to-Sink (Conductive grease applied)	0.035		°C/W
Weight	Weight of Module	240		g

FMG2G50US120



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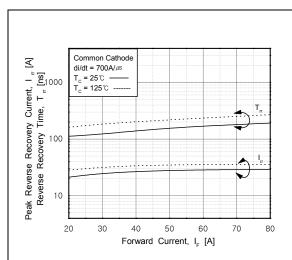
FMG2G50US120 Rev. A

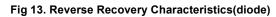


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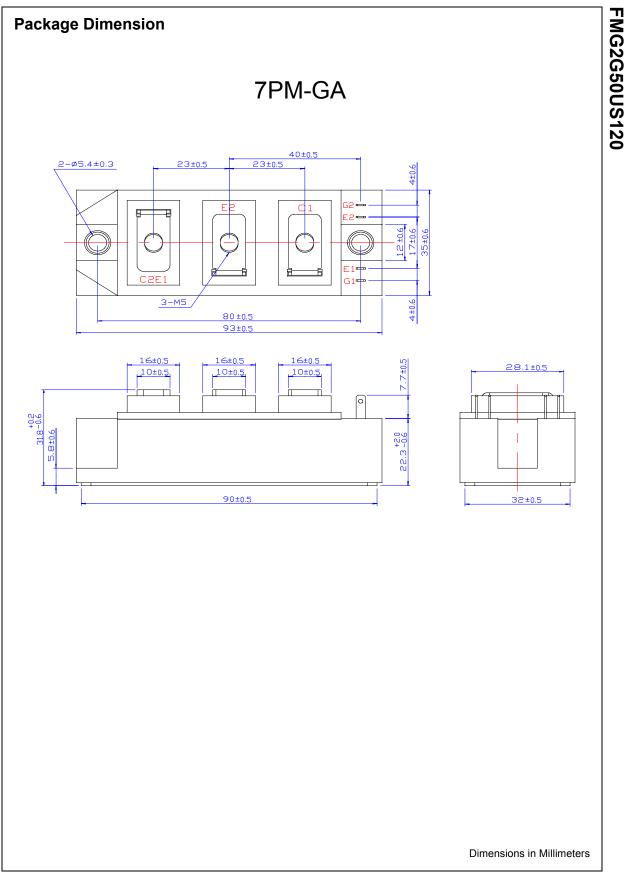
# FMG2G50US120





FMG2G50US120

**Dimensions in Millimeters** 



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